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Instrument transformers – The use of instrument transformers for power quality measurement

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CONTENTS

FOREWORD 6
1 Scope 8
2 Normative references 8
3 Terms and definitions 9
4 Nature of the problem 12
5 Power quality parameters according to IEC 61000-4-30:2008 13
5.1 General 13
5.2 Power quality measurement chain 13
5.3 Signal processing according to IEC 61000-4-30:2008 14
5.4 Power frequency 15
5.5 Magnitude of the supply voltage 15
5.6 Flicker 15
5.7 Supply voltage dips and swells 17
5.8 Voltage interruptions 18
5.9 Transient voltages 19
5.10 Supply voltage unbalance 19
5.11 Voltage harmonics 20
5.12 Voltage inter-harmonics 21
5.13 Mains Signalling Voltages on the supply voltage 21
5.14 Rapid voltage changes 21
5.15 Measurement of underdeviation and overdeviation parameters 21
5.16 Summary of the requirements placed by the measure of power quality parameters 21
6 Impact of instrument transformers on PQ measurement 22
6.1 General 22
6.2 Inductive instrument transformers 24
6.2.1 Inductive voltage transformers 25
6.2.2 Inductive CTs 30
6.3 Capacitive voltage transformers (CVTs) 35
6.3.1 Standard application 35
6.3.2 Special measurement techniques 39
6.4 Electronic instrument transformers 42
6.4.1 General 42
6.4.2 Common accuracy classes 42
6.4.3 Electronic VTs 43
6.4.4 Electronic CTs 55
7 Tests for power quality 67
7.1 Test procedure for VT frequency response 68
7.2 Test set-up for VT frequency response test 68
7.3 Test procedure for CT frequency response 70
7.4 Test set-up for CT frequency response test 70
7.5 Special considerations for test of electronic instrument transformers with digital output 72
7.6 Tests for electronic instrument transformers according to IEC Standard 60044-8 72
7.6.1 Test arrangement and test circuit 73

Annex A Instrument transformers and power quality measurement – open issues 75
Annex B Transformer classes 79
Bibliography 81

Figure 1 – Measurement chain (From [8], modified) 14
Figure 2 – Contribution of instrument transformers in overall measurement uncertainty (from [9], modified) 14
Figure 3 – Example of voltage fluctuation causing flicker 16
Figure 4 – Demodulation within the IEC flickermeter 17
Figure 5 – Example of voltage dip (courtesy of Italian distribution network monitoring system – QuEEN) 18
Figure 6 – Example of voltage interruption (courtesy of Italian distribution network monitoring system – QuEEN) 19
Figure 7 – Example of voltage unbalance (courtesy of Italian distribution network monitoring system- QuEEN) 20
Figure 8 – Example of voltage harmonics 21
Figure 9 – Voltage transformer technologies frequency range according to present experience 23
Figure 10 – Current transformer technologies frequency range according to present experience 24
Figure 11 – Example of equivalent circuit for an inductive voltage/current transformer 25
Figure 12 – Cross-section view of an inductive voltage transformer for voltages over 1 kV and up to 52 kV (courtesy of Schneider Electric) 26
Figure 13 – Cross-section view of a freestanding High Voltage VT (courtesy of Trench Switzerland AG) 28
Figure 14 – Frequency response of a typical inductive VT 420 kV (courtesy of Trench Switzerland AG) 29
Figure 15 – First resonance peak depending on the system voltage U_m (courtesy of Trench Switzerland AG) 29
Figure 16 – Cross-section view of a current transformer (courtesy of Schneider Electric) 32
Figure 17 – Results obtained for a 245 kV CT (courtesy of Trench Switzerland AG) 34
Figure 18 – Results obtained for a 245 kV CT: detail (courtesy of Trench Switzerland AG) 34
Figure 19 – Cross-section view of a capacitive voltage transformer (Courtesy of Trench Switzerland AG) 35
Figure 20 – CVT: Equivalent circuit at power frequency 36
Figure 21 – Simplified CVT Thevenin equivalent circuit at power frequency without compensating reactor 37
Figure 22 – Simplified CVT Thevenin equivalent circuit at power frequency 37
Figure 23 – Complete CVT Thevenin equivalent circuit at power frequency 38
Figure 24 – Measurements performed by means of a CVT with harmonic measurement terminal 40
Figure 25 – Comparison of different measurements with and without harmonic monitoring terminal (Courtesy of Trench Switzerland AG, based on [16]) 41
Figure 26 – Basic design for a bulk crystal producing a Pockels Effect (courtesy of Alstom Grid) 45
Figure 27 – Various solutions to apply voltage on the active crystal 46
Figure 28 – Various methods to divide the full voltage before applying on the crystal 46

Figure 29 – Basic design for a Pockels sensor (courtesy of Alstom Grid) 47
Figure 30 – Industrial bulk Pockels Cell (courtesy of Alstom Grid)..... 47
Figure 31 – Frequency response calculation for an optical VT (courtesy of Alstom Grid)..... 48
Figure 32 – Cross-section view and electrical scheme of a resistive voltage divider (from [22])..... 49
Figure 33 – Ratio error of an MV resistive divider (courtesy of Trench Switzerland AG) 50
Figure 34 – Phase error of MV resistive divider (courtesy of Trench Switzerland AG)..... 50
Figure 35 – Electrical scheme of a capacitive voltage divider..... 51
Figure 36 – Equivalent circuit of an RC voltage divider (from [23], [24]) 53
Figure 37 – Equivalent circuit of a balanced RC voltage divider (from [24]) 53
Figure 38 – Frequency response of an RC voltage divider (courtesy of Trench Switzerland AG)..... 54
Figure 39 – Measurements done on an RC voltage divider with a voltage level of 145 kV with a cable length of 150 m (courtesy of Trench Switzerland AG) 54
Figure 40 – Principle of optical CT measurement (from [22])..... 56
Figure 41 – Principle of optical CT measurement (Courtesy of Alstom Grid)..... 56
Figure 42 – Frequency response calculation for an optical CT (Courtesy of Alstom Grid) 57
Figure 43 – Typical frequency response measurement of a LPCT (Courtesy of Trench Switzerland AG)..... 58
Figure 44 – Equivalent circuit for a Rogowski coils (Courtesy of Alstom Grid)) 59
Figure 45 – Electrical scheme and picture of a Rogowski current transformer (Courtesy of Alstom Grid)..... 61
Figure 46 – Electrical scheme of a shunt current measurement (Courtesy of Alstom Grid) 62
Figure 47 – Shunt for DC application (Courtesy of Alstom Grid) 63
Figure 48 – Equivalent circuit for a compensated shunt 63
Figure 49 – Theoretic possible bandwidth of a shunt 5 kA /150 mV (Courtesy of Alstom Grid) 64
Figure 50 – Hall Effect Sensor 65
Figure 51 – Hall Effect Sensor (Courtesy of Schneider Electric – From [38]) 66
Figure 52 – Hall Effect Sensor (Courtesy of Schneider Electric – From [38]) 66
Figure 53 – Test circuit for VT frequency response test 69
Figure 54 – Test circuit for VT frequency response test 70
Figure 55 – Test circuit for CT frequency response test 71
Figure 56 – Test circuit for CT frequency response test 72
Figure 57 – Test set-up for electronic instrument current transformers with digital output 73
Figure 58 – Test set-up for electronic current transformers with analogue output 74
Figure A.1 – Examples of “fake dips”, transients recorded at the secondary winding of MV voltage transformers due to voltage transformers saturation (courtesy of Italian distribution network monitoring system- QuEEN)..... 78

Table 1 – Power quality disturbances and measurement interval as per IEC 61000-4-30:2008 15
Table 2 – Transformer parameters influencing power quality measurement..... 22

Table 3 – Main components of an inductive voltage transformer for voltages over 1 kV and up to 52 kV 26
Table 4 – Inductive voltage transformers for voltages over 1 kV and up to 52 kV: impact on the measurements of PQ Parameters 27
Table 5 – Inductive voltage transformers for voltages over 52 kV and up to 1 100 kV: impact on the measurements of PQ parameters 30
Table 6 – Main components of an inductive current transformer for voltages over 1 kV up to 52 kV 31
Table 7 – Inductive CTs for voltages over 1 kV up to 52 kV: impact on the measurements of PQ parameters 32
Table 8 – Main components of an inductive current transformer for voltages above 52 kV up to 1 100 kV 33
Table 9 – Inductive CTs for voltages over 52 kV up to 1 100 kV: impact on the measurements of PQ parameters 35
Table 10 – Capacitive voltage transformers: impact on the measurements of PQ parameters 39
Table 11 – Capacitive voltage transformer with harmonic measurement terminal: impact on the measurements of PQ parameters 41
Table 12 – Capacitive voltage transformer with additional equipment for PQ measurement: impact on the measurements of PQ parameters 42
Table 13 – Accuracy classes for power metering 43
Table 14 – Accuracy classes for power quality metering 43
Table 15 – Optical voltage transformer: impact on the measurements of PQ parameters 48
Table 16 – MV resistive divider: impact on the measurements of PQ parameters 51
Table 17 – Capacitive voltage dividers: impact on the measurements of PQ parameters 52
Table 18 – RC voltage divider: impact on the measurements of PQ parameters 55
Table 19 – Optical current transformer: Impact on the measurements of PQ parameters 57
Table 20 – Main components of LPCTs 58
Table 21 – Main components of Rogowski sensors 61
Table 22 – Rogowski current transformer: Impact on the measurements of PQ parameters 62
Table 23 – Shunt: Impact on the measurements of PQ parameters 64
Table 24 – Hall effect sensor: Impact on the measurements of PQ parameters 67
Table 25 – Power quality parameters and requirements for CT and VT 68
Table 26 – Test currents and voltages for the common accuracy classes 72
Table 27 – Test currents and voltages for special accuracy classes 72
Table B.1 – Example of test table with possible main requirements for accuracy tests 80

INTERNATIONAL ELECTROTECHNICAL COMMISSION

INSTRUMENT TRANSFORMERS – THE USE OF INSTRUMENT TRANSFORMERS FOR POWER QUALITY MEASUREMENT

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IEC 61869-103, which is a technical report, has been prepared by IEC technical committee 38: Instrument transformers.

The text of this technical report is based on the following documents:

Enquiry draft	Report on voting
38/402/DTR	38/409/RVC

Full information on the voting for the approval of this technical report can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all the parts in the IEC 61869 series, published under the general title *Instrument transformers*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability dateindicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
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INSTRUMENT TRANSFORMERS – THE USE OF INSTRUMENT TRANSFORMERS FOR POWER QUALITY MEASUREMENT

1 Scope

This part of IEC 61869 is applicable to inductive and electronic instrument transformers with analogue or digital output for use with electrical measuring instruments for measurement and interpretation of results for power quality parameters in 50/60 Hz a.c. power supply systems.

This part of IEC 61869 aims at giving guidance in the usage of HV instrument transformers for measuring power quality parameters.

The power quality parameters considered in this document are power frequency, magnitude of the supply voltage and current, flicker, supply voltage dips and swells, voltage interruptions, transient voltages, supply voltage unbalance, voltage and current harmonics and interharmonics, mains signalling on the supply voltage and rapid voltage changes.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60044-8:2002, *Instrument transformers – Part 8: Instrument transformers: Electronic current transformers*

IEC 61000-2-1:1990, *Electromagnetic compatibility (EMC) – Part 2-1: Environment – Description of the environment – Electromagnetic environment for low-frequency conducted disturbances and signalling in public power supply systems*

IEC 61000-2-2:2002, *Electromagnetic compatibility (EMC) – Part 2-2: Environment – Compatibility for low frequency conducted disturbances and signalling in public low-voltage power supply systems*

IEC 61000-4-7:2002, *Electromagnetic compatibility (EMC) – Part 4-7: Testing and measurement techniques – General guide on harmonics and interharmonics measurements and instrumentation, for power supply systems and equipment connected thereto*

IEC 61000-4-15:2010, *Electromagnetic compatibility (EMC) – Part 4-15: Testing and measuring techniques – Flickermeter – Functional and design specifications*

IEC 61000-4-30:2008, *Electromagnetic compatibility (EMC) – Part 4-30: Testing and measurement techniques – Power quality measurement methods*

IEC 60359:2001, *Electrical and electronic measurement equipment – Expression of performance*

IEC 61557-12:2007, *Electrical safety in low voltage distribution systems up to 1 000 V a.c. and 1 500 V d.c. – Equipment for testing, measuring or monitoring of protective measures – Part 12: Performance measuring and monitoring devices (PMD)*

EN 50160:2007, *Voltage characteristics of electricity supplied by public distribution networks*